GKS-075 201 064 A 1000

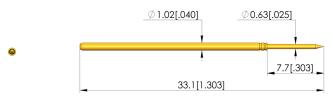
Item GKS-075-0056





- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- · Various spring forces available as well as versions with stainless steel springs suitable for high temperatures
- Used for setting the optimum stroke conditions in the test fixture, various installation heights can be achieved by combining test probes and receptacles







General data

Product group: ICT / FCT (in-circuit test and function test Sub-product group: Standard stroke test probe Series: GKS-075 Grid: 1.91 mm [75.1 mil] Contacting from: Pad Magnetic: Yes Plug-in Installation type: Quick-exchange system: Adjustable installation height: Non-rotating: No Compatible receptacle(s): KS-075 -40 °C [-40 °F] Min. temperature: Max. temperature: 80 °C [176 °F] RoHS-compliant:

Tip style data

Tip style:	01 30° needle tip, self-cleaning
Tip diameter:	0.64 mm [.025 in]
Tip style surface:	A gold
Tip style material:	2 steel

Electrical data

Current load capacity / rated current: 3 A Typical resistance (Ri): 20 mOhm

Mechanical data

Yes

Total length:	33.1 mm [1.3 in]
Barrel diameter:	1.02 mm [.04 in]
Maximum stroke:	6.35 mm [.25 in]
Spring pre-load:	0.4 N [1.43 ozf]
Collar height:	0
Spring force at working stroke:	1 N [3.59 ozf]
Recommended working stroke:	4.3 mm [.169 in]

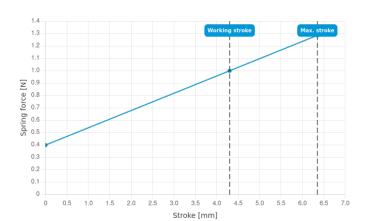
Partner for Future Technology

ICT/FCT TEST PROBES

Test Probe GKS-075 201 064 A 1000

Item GKS-075-0056





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Learn more about **ICT/FCT Test probes**

